

<b>Notice of References Cited</b>	Application/Control No. 10/580,890		Applicant(s)/Patent Under Reexamination YANG KOOK ET AL.	
	Examiner Katherine Turner		Art Unit 1795	Page 1 of 1

#### U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2003/0170540	09-2003	Ohzuku et al.	429/231.1
*	B	US-2002/0164527	11-2002	Tanigawa et al.	429/223
*	C	US-6,071,489	06-2000	Sun et al.	423/594.4
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

#### FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

#### NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	vane, Collins English Dictionary, 2000, [online], [retrieved on 2009-12-10], Retrieved from Credoreference using Internet <URL: <a href="http://www.credoreference.com/entry/hcengdict/vane">http://www.credoreference.com/entry/hcengdict/vane</a> >
	V	baffle, Chambers 21st Century Dictionary, 2001, [online], [retrieved on 2009-12-10], Retrieved from Credoreference using Internet <URL: <a href="http://www.credoreference.com/entry/chambdict/baffle">http://www.credoreference.com/entry/chambdict/baffle</a> >
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
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